

**Search Notes**

Application/Control No.

10/624,173

Examiner

Devin Hanan

Applicant(s)/Patent under  
Reexamination

BAUMANN ET AL.

Art Unit

3745

**SEARCHED**

Class	Subclass	Date	Examiner
415	202,203		
416	185,186R	2/2/2007	DH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
consulted Ninh Nguyen on class 415 and 416	1/25/2007	DH